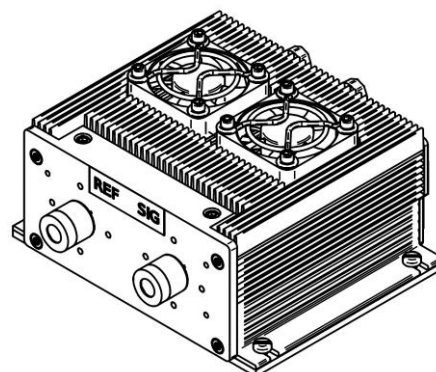


NIPM-I-10

PRELIMINARY DATASHEET

Balanced/autobalanced IR detection module based on two InAsSb superlattice thermoelectrically cooled optically immersed photovoltaic detectors



FEATURES

- Spectral range: 1.8 to 11.3 μm
- Frequency bandwidth: DC to 2.0 MHz (typ.)
- RoHS-compliant III-V material
- Back-side illuminated
- Unique immersion lens technology applied
- Two channels with similar spectral and frequency characteristics
- Manual switch between balance and autobalance modes
- Integrated two TEC controllers and two fans
- Low-noise performance and high detectivity
- Single power supply
- M6 mounting hole
- Compatible with optical accessories

APPLICATIONS

- Gas detection, monitoring and analysis: SO_2 , NH_3 , SF_6
- Excess noise suppression of Quantum Cascade Laser (QCL) in gas analysis

INCLUDED ACCESSORIES

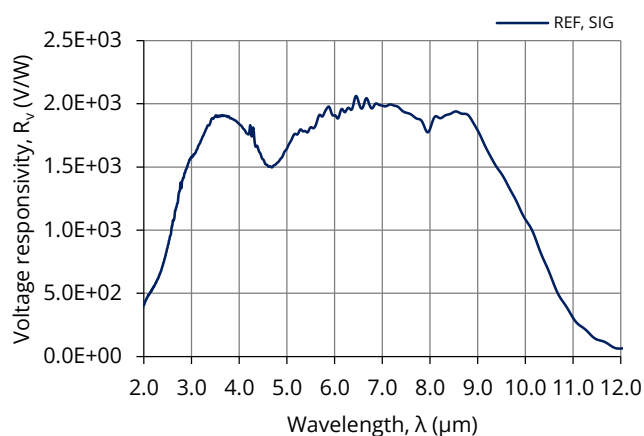
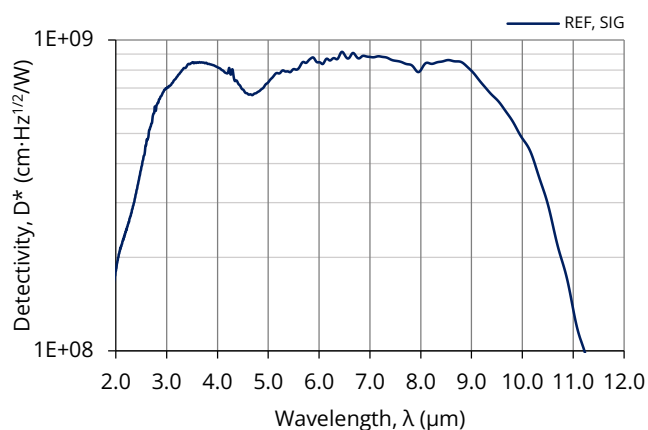
- 3 pcs of SMA-BNC cable
- 1 pc of AC adaptor

DETECTION MODULE CONFIGURATION

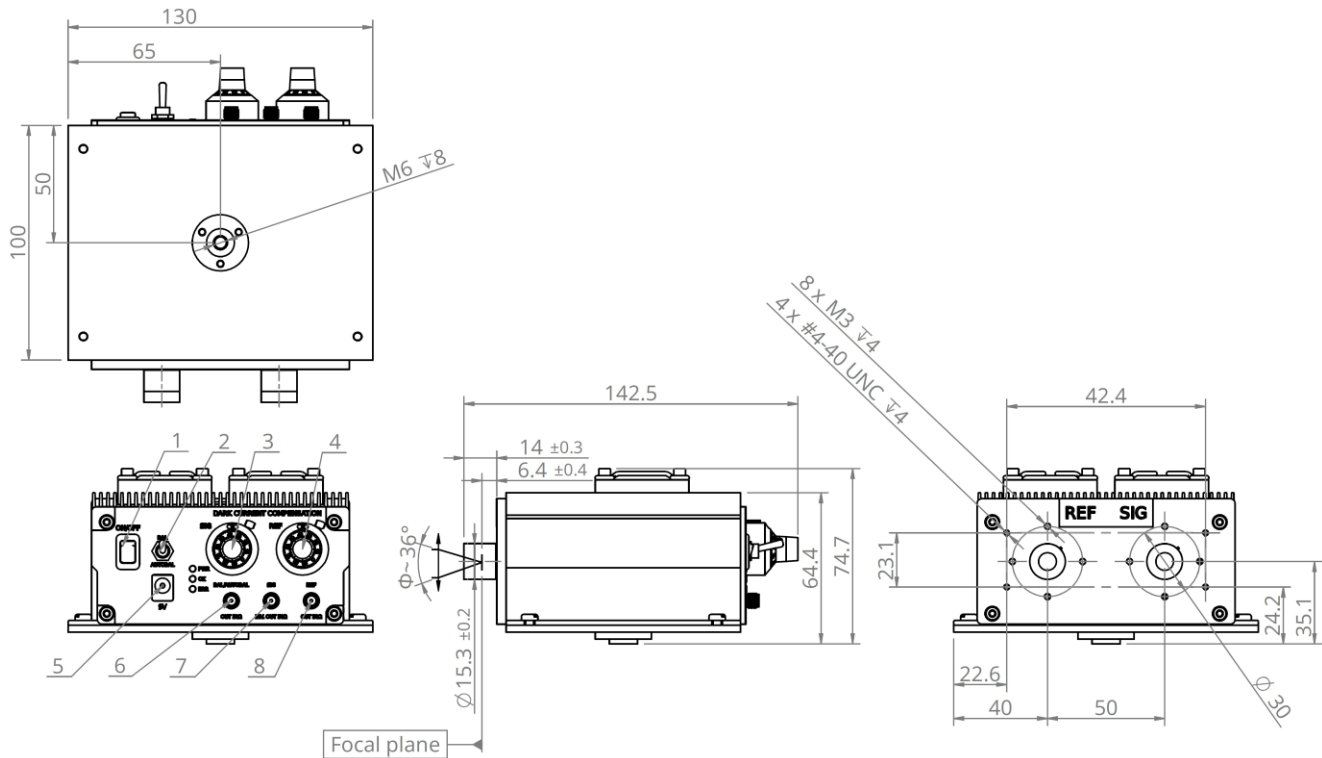
| | |
|--|---|
| Detection module symbol | NIPM-I-10 |
| Number of detectors | 2 pcs |
| Detectors symbol | PVIA-10-1x1-TO8-wZnSeAR-36 |
| Detectors type | photovoltaic |
| Active element material | epitaxial InAsSb superlattice heterostructure |
| Optical area, A_o | 1 mm \times 1 mm |
| Optical immersion | yes |
| Cooling | 4TE ($T_{\text{chip}} \cong 210\text{K}$) |
| Acceptance angle, Φ | ~ 36 deg. |
| Window | wZnSeAR (3 deg. zinc selenide, anti-reflection coating) |
| Amplifier type | two-channel, balanced/autobalanced, transimpedance |
| Reference output socket (REF) | SMA |
| Signal output socket (SIG) | SMA |
| Balance/autobalance socket (BAL/AUTOBAL) | SMA |
| Power supply socket | DC 2.1/5.5 |

SPECIFICATION ($T_{\text{amb}} = 293 \text{ K}$, $T_{\text{chip}} = 210 \text{ K}$, $R_{\text{load}} = 50 \Omega$)

| Parameter | Test conditions, remarks | Value | | | Unit |
|---|---|-------|-------------------|------|--|
| | | Min. | Typ. | Max. | |
| Active element temperature, T_{chip} | | - | 210 | - | K |
| Cut-on wavelength, $\lambda_{\text{cut-on}} (10\%)$ | At 10% of peak responsivity | - | 1.8 | - | μm |
| Peak wavelength, λ_{peak} | | - | 6.7 | - | μm |
| Specific wavelength, λ_{spec} | | - | 10.0 | - | μm |
| Cut-off wavelength, $\lambda_{\text{cut-off}} (10\%)$ | At 10% of peak responsivity | - | 11.3 | - | μm |
| Detectivity, D^* | REF, at $\lambda = \lambda_{\text{spec}}$, $f = 100 \text{ kHz}$ | - | 8.0×10^8 | - | $\text{cm} \cdot \text{Hz}^{1/2} / \text{W}$ |
| | SIG, at $\lambda = \lambda_{\text{spec}}$, $f = 100 \text{ kHz}$ | - | 8.0×10^8 | - | |
| Output noise voltage density, v_n | REF, at $f = 100 \text{ kHz}$ | - | 400 | - | $\text{nV}/\text{Hz}^{1/2}$ |
| | SIG, at $f = 100 \text{ kHz}$ | - | 400 | - | |
| Voltage responsivity, R_v | REF, at $\lambda = \lambda_{\text{spec}}$ | - | 1.8×10^3 | - | V/W |
| | SIG, at $\lambda = \lambda_{\text{spec}}$ | - | 1.8×10^3 | - | |
| Low cut-off frequency, f_{lo} | DC coupling | - | 0 | - | Hz |
| High cut-off frequency, f_{hi} | | - | 2.0 | - | MHz |
| Output impedance, R_{out} | REF, SIG, BAL/AUTOBAL | - | 50 | - | Ω |
| Output voltage swing, V_{out} | | - | ± 0.4 | - | V |
| Output voltage offset, V_{off} | | - | ± 30 | - | mV_{DC} |
| Common mode rejection ratio, CMRR (balance) | REF, at $f = 100 \text{ kHz}$ | - | -26 | - | dB |
| Common mode rejection ratio, CMRR (auto-balance) | REF, at $f = 100 \text{ kHz}$ | - | -20 | - | dB |
| Power supply voltage, V_{sup} | | - | +9 | - | V_{DC} |
| Power supply current consumption, I_{sup} | | - | 1.5 | - | A |

SPECTRAL RESPONSE (Typ., $T_{\text{amb}} = 293 \text{ K}$, $T_{\text{chip}} = 210 \text{ K}$, REF and SIG)


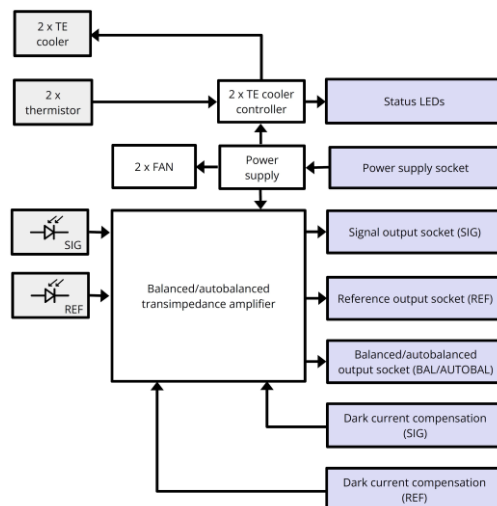
MECHANICAL LAYOUT (Unit: mm)



MARKING DESCRIPTION

1. Power switch
2. Balance/autobalance switch
3. Dark current compensation – signal
4. Dark current compensation – reference
5. Power supply
6. Balance/autobalance output
7. Signal output
8. Reference output

SCHEMATIC DIAGRAM



ABSOLUTE MAXIMUM RATINGS

| Parameter | Test conditions, remarks | Value | Unit |
|--|--|-----------|--------------------|
| Ambient operating temperature, T_{amb} | | 10 to 30 | °C |
| Storage temperature, T_{stg} | | -20 to 50 | °C |
| Minimum time at room temperature before power-up | Applies after storage or transport at temperatures outside ambient range. Required to prevent condensation or damage due to thermal stress | 12 | h |
| Humidity | No dew condensation | 10 to 90 | % |
| Maximum incident optical power density | Continuous wave (CW) or single pulses >1 μ s duration | 2.5 | W/cm ² |
| | Single pulses <1 μ s duration | 10 | kW/cm ² |

Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. Constant or repeated exposure to absolute maximum rating conditions may affect the quality and reliability of the device.